

<b>Notic of References Cited</b>	Application/Control No. 10/702,379	Applicant(s)/Patent Under Reexamination ORTT ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,268,607	12-1993	McManus, Edward C.	310/89
X	B	US-5,861,695	01-1999	Brassard, Serge	310/156.43
X	C	US-5,475,276	12-1995	Shiga et al.	310/154.19
X	D	US-4,015,154	03-1977	Tanaka et al.	310/42
X	E	US-4,873,461	10-1989	Brennan et al.	310/47
X	F	US-5,475,276	12-1995	Shiga et al.	310/154.19
X	G	US-4,682,066	07-1987	Abbratozzato et al.	310/154.09
X	H	US-4,935,655	06-1990	Ebner, Jens	310/154.29
X	I	US-2002/0079769	06-2002	Akiwa, Naotaka	310/156.06
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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